

<HVIC>

M81738FP

1200V HIGH VOLTAGE HALF BRIDGE DRIVER

DESCRIPTION

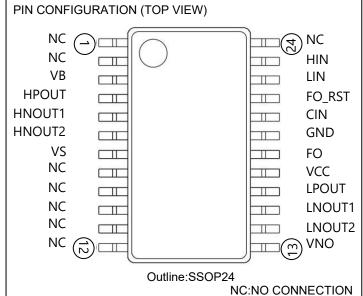
M81738FP is high voltage Power MOSFET and IGBT gate driver for half bridge applications.

FEATURES

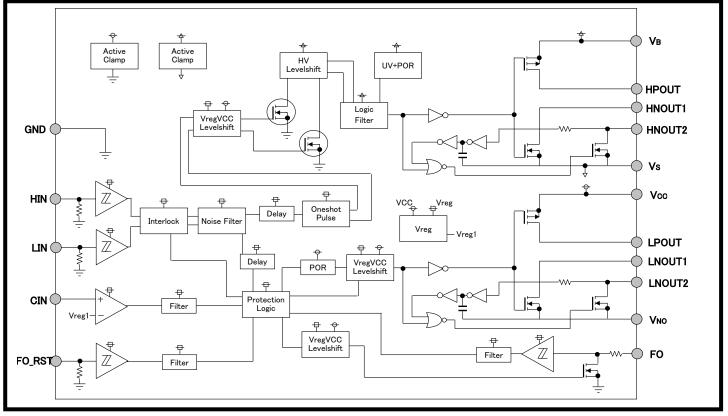
- •Floating supply voltage up to 1200V
- •Low quiescent power supply current
- •Separate sink and source current output up to ±1A (typ)
- •Active Miller effect clamp NMOS with sink current up to 1A (typ)
- •Input noise filters (HIN,LIN,FO_RST,FO)
- •Over-current detection and output shutdown
- High side under voltage lockout
- •FO pin which can input and output Fault signals to communicate with controllers and synchronize the shut down with other phases
- •Active clamp (power supply surge clamp)
- •24-Lead SSOP PACKAGE

APPLICATIONS

Power MOSFET and IGBT gate driver for Medium and Micro inverter or general purpose.



BLOCK DIAGRAM



ABSOLUTE MAXIMUM RATINGS

Absolute maximum ratings indicate limitation beyond which destruction of device may occur. All voltage parameters are absolute voltage reference to GND unless otherwise specified.

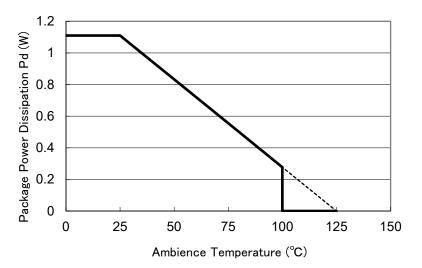
Symbol	Parameter	Test conditions	Ratings	Unit
V _B	High side floating supply absolute voltage		-0.5 ~ 1224	V
Vs	High side floating supply offset voltage		V _B -24 ~ V _B +0.5	V
V _{BS}	High side floating supply voltage	V _{BS} =V _B -V _S	-0.5 ~ 24	V
V _{HO}	High side output voltage		V _S -0.5 ~ V _B +0.5	V
V _{CC}	Low side fixed supply voltage		-0.5 ~ 24	V
V _{NO}	Power ground		V_{CC} -24 ~ V_{CC} +0.5	V
V _{LO}	Low side output voltage		V_{NO} -0.5 ~ V_{CC} +0.5	V
V _{IN}	Logic input voltage	HIN, LIN, FO_RST	-0.5 ~ V _{CC} +0.5	V
V _{FO}	FO input/output voltage		-0.5 ~ V _{CC} +0.5	V
V _{CIN}	CIN input voltage		-0.5 ~ V _{CC} +0.5	V
dV _S /dt	Allowable offset voltage slew rate	V _s -GND	±50	V/ns
Pd	Package power dissipation	Ta= 25°C ,On our standard PCB	~ 1.11	W
Kq	Linear derating factor	Ta≧25°C ,On our standard PCB	~ 11.1	mW/°C
Rth(j-a)	Junction-ambient air thermal resistance	On our standard PCB	~ 90	°C/W
Tj	Junction temperature		-40 ~ 125	°C
Topr	Operation temperature		-40 ~ 100	°C
Tstg	Storage temperature	On PCB	-40 ~ 150	°C
TL	Solder reflow condition	Pb-free	255:10s, max260	°C

RECOMMENDED OPERATING CONDITIONS

For proper operation the device should be used within the recommended conditions. All voltage parameters are absolute voltages referenced to GND unless otherwise specified.

Symbol	Parameter	Test conditions						
Symbol	Falalletei	Test conditions	Min.	Тур.	Max.	Unit		
V _B	High side floating supply absolute voltage		V _s +13.5	V _s +15	V _s +20	V		
Vs	High side floating supply offset voltage	V _{BS} > 13.5V	-5	-	900	V		
V _{BS}	High side floating supply voltage	$V_{BS} = V_{B} - V_{S}$	13.5	15	20	V		
V _{HO}	High side output voltage		Vs	-	V _s +20	V		
V _{cc}	Low side fixed supply voltage		13.5	15	20	V		
V _{NO}	Power ground		-0.5	-	5	V		
V _{LO}	Low side output voltage		V _{NO}	-	V _{cc}	V		
V _{IN}	Logic input voltage	HIN, LIN, FO_RST	0	-	V _{cc}	V		
V _{FO}	FO input/output voltage		0	-	V _{cc}	V		
V _{CIN}	CIN input voltage		0	-	5	V		

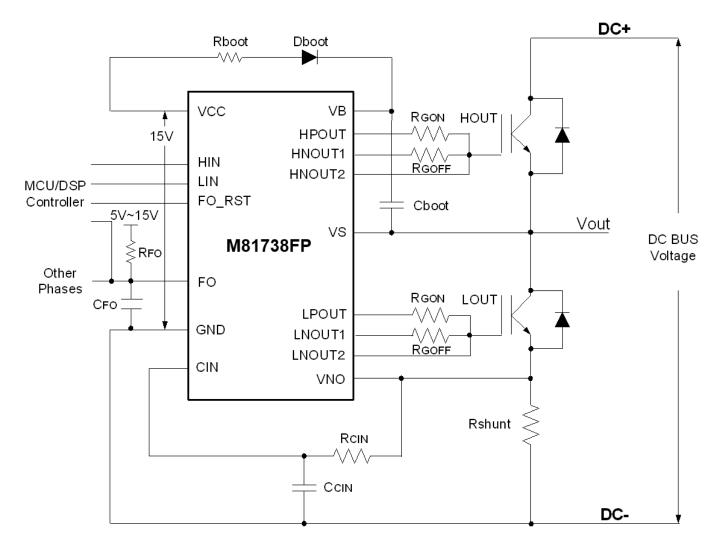
THERMAL DERATING FACTOR CHARACTERISTIC (MAXIMUM RATING)



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TYPICAL CONNECTION



Note: If HVIC is working in high noise environment, it is recommended to connect a 1nF ceramic capacitor (CFO) to FO pin.

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Symbol	Parameter	Test conditions		Limits		Unit
			Min.	Тур.	Max.	
FS	High side leakage current	$V_{B} = V_{S} = 1200V$	-	-	10	uA
BS	V _{BS} quiescent supply current	HIN = LIN = 0V	-	0.5	0.8	mA
lcc	V _{CC} quiescent supply current	HIN = LIN = 0V	-	1.0	1.5	mA
V _{OH}	High level output voltage	I _o = 0A, HPOUT, LPOUT	14.5	-	-	V
V _{OL}	Low level output voltage	I _o = 0A, HNOUT1, LNOUT1	-	-	0.5	V
VIH	High level input threshold voltage	HIN, LIN, FO_RST	2.2	3.0	4.0	V
VIL	Low level input threshold voltage	HIN, LIN, FO_RST	0.6	1.5	2.1	V
l _{ін}	High level input bias current	V _{IN} = 5V	0.6	1.0	1.4	mA
l _{iL}	Low level input bias current	V _{IN} = 0V	0.00	0.00	0.01	mA
		HIN on-pulse	80	200	500	ns
		HIN off-pulse	80	200	500	ns
tFilter	Input signals filter time	LIN on-pulse	80	200	500	ns
		LIN off-pulse	80	200	500	ns
		FO_RST on-pulse	80	200	500	ns
		FO off-pulse	80	200	500	ns
V _{HNO2}	High side active Miller clamp NMOS input threshold voltage	V _{IN} = 0V	2.0	3.4	5.0	V
V _{LNO2}	Low side active Miller clamp NMOS input threshold voltage	V _{IN} = 0V	6.0	7.6	9.0	V
tV _{NO2}	Active Miller clamp NMOS filter time	V _{IN} = 0V	-	400	-	ns
V _{OLFO}	Low level FO output voltage	I _{FO} = 1mA	-	-	0.95	V
VIHFO	High level FO input threshold voltage		2.2	3.0	4.0	V
V _{ILFO}	Low level FO input threshold voltage		0.6	1.5	2.1	V
V _{BSuvr}	V _{BS} supply UV reset voltage		10.5	11.3	12.1	V
V _{BSuvt}	V _{BS} supply UV trip voltage		10.0	10.8	11.6	V
V _{BSuvh}	V _{BS} supply UV hysteresis voltage	V _{BSuvh} = V _{BSuvr} -V _{BSuvt}	0.2	0.5	0.8	V
tV _{BSuv}	V _{BS} supply UV filter time		4	8	16	us
V _{CIN}	CIN trip voltage		0.40	0.50	0.60	V
V _{POR}	POR trip voltage		4.0	5.5	7.5	V
он	Output high level short circuit pulsed current	HPOUT(LPOUT) = 0V, V_{IN} = 5V, PW \leq 10us	-	1	-	А
I _{OL1}	Output low level short circuit pulsed current	HNOUT1(LNOUT1) = 15V, V_{IN} = 0V, PW \leq 10us	-	-1	-	A
I _{OL2}	Active Miller clamp NMOS output low level short circuit pulsed current	HNOUT2(LNOUT2) = 15V, V_{IN} = 0V, PW \leq 10us	-	-1	-	А
R _{OH}	Output high level on resistance	I ₀ = 1А, R _{OH} = (V _{OH} -V ₀)/I ₀	-	15	-	Ω
R _{OL1}	Output low level on resistance	I ₀ = -1A, R _{0L1} = V ₀ /I ₀	-	15	-	Ω
R _{OL2}	Active Miller clamp NMOS output low level on resistance	$I_0 = -1A, R_{0L2} = V_0/I_0$	-	15	-	Ω
tdLH(HO)	High side turn-on propagation delay	HPOUT short to HNOUT1 and HNOUT2, CL = 1nF	1.00	1.27	1.62	us
tdHL(HO)	High side turn-off propagation delay	HPOUT short to HNOUT1 and HNOUT2, CL = 1nF	0.90	1.21	1.47	us
tdLH(LO)	Low side turn-on propagation delay	LPOUT short to LNOUT1 and LNOUT2, CL = 1nF	1.00	1.39	1.90	us
tdHL(LO)	Low side turn-off propagation delay	LPOUT short to LNOUT1 and LNOUT2, CL = 1nF	0.90	1.19	1.70	us
r	Output turn-on rise time	CL = 1nF	10	40	80	ns
f	Output turn-off fall time	CL = 1nF	10	40	80	ns
DtdLH	Delay matching, high side turn-on and low side turn-off	tdLH(HO)-tdHL(LO)	-100	80	300	ns
DtdHL	Delay matching, high side turn-off and low side turn-on	tdLH(LO)-tdHL(HO)	-20	180	400	ns
V _{clamp}	Active clamp voltage	V_{cc} – GND, V_{B} - V_{S}	24	-	-	V

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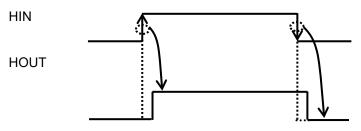
FUNCTION TABLE (Q: Keep previous status)

				FO	V _{BS} /	V _{cc} /			FO		
HIN	LIN	FO_RST	CIN	(Input)	UV • POR	POR	HOUT	LOUT	(Output)	Behavioral status	
L	L	L	L	-	Н	Н	L	L	Н		
L	н	L	L	-	Н	Н	L	Н	Н		
н	L	L	L	-	Н	Н	Н	L	Н		
н	н	L	L	-	Н	Н	Q	Q	Н	Interlock active	
х	Н	х	Н	-	х	Н	L	L	L	CIN tripping when LIN = H	
х	L	х	Н	-	х	Н	Q	Q	Н	CIN not tripping when LIN = L	
х	х	х	Х	L	х	Н	L	L	-	Output shuts down when FO = L	
х	х	х	х	-	х	L	L	L	Н	V _{cc} power reset	
х	L	L	L	-	L	Н	L	L	Н	V _{BS} power reset	
х	н	L	L	-	L	Н	L	Н	Н	V_{BS} power reset is tripping when LIN = H	

Note1 : "L" status of VBS/UV indicates a high side UV condition; "L" status of VCC/POR indicates a VCC power reset condition.

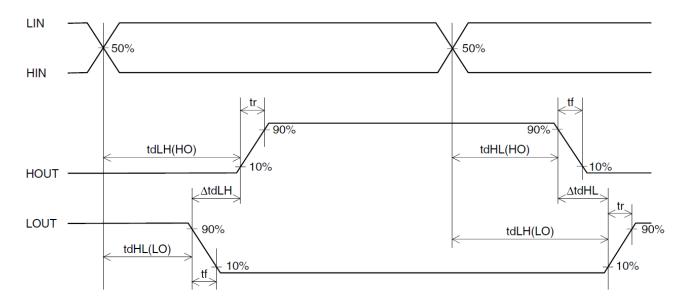
Note2 : In the case of both input signals (HIN and LIN) are "H", output signals (HOUT and LOUT) keep previous status.

Note3 : X (HIN) : L \rightarrow H or H \rightarrow L. Other : H or L. Note4 : Output signal (HOUT) is triggered by the edge of input signal.



FUNCTIONAL DESCRIPTION

1. INPUT/OUTPUT TIMING DIAGRAM

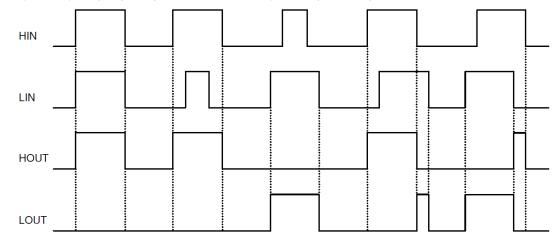


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2. INPUT/OUTPUT TIMING DIAGRAM

When the input signals (HIN/LIN) are high level at the same time, the outputs (HOUT/LOUT) keep their previous status. But if signals (HIN/LIN) are going to high level simultaneously, HIN signals will get active and cause HOUT to enter "H" status.



Note1 : The minimum input pulse width at HIN/LIN should be to more than 500ns (because of HIN/LIN input noise filter circuit).

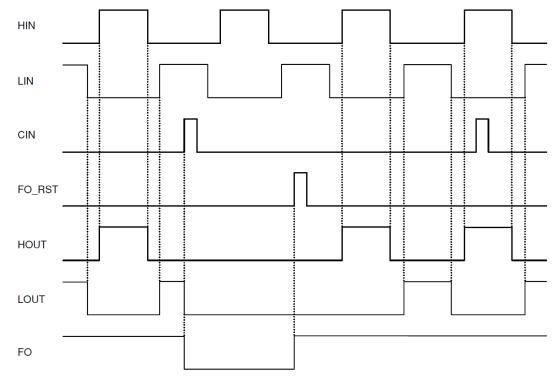
Note2 : If a high-high status of input signals (HIN/LIN) is ended with only one input signal entering low level and another still being in high level, the output will enter high-low status after the delay match time (not shown in the figure above).

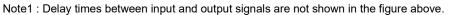
Note3 : Delay times between input and output signals are not shown in the figure above.

3. SHORT CIRCUIT PROTECTION TIMING DIAGRAM

When an over-current is detected by exceeding the threshold at the CIN and LIN is at high level at the same time, the short circuit protection will get active and shutdown the outputs while FO will issue a low level (indicating a fault signal).

The fault output latch is reset by a high level signal at FO_RST pin and then FO will return to high level while the output of the driver will respond to the following active input signal.





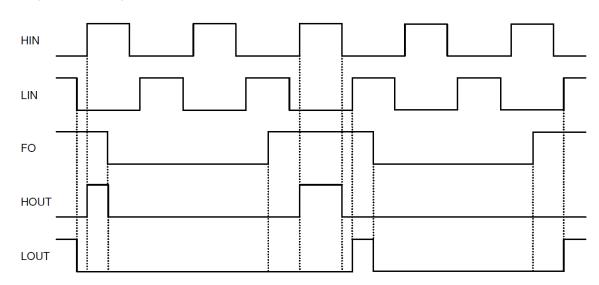
Note2 : The minimum FO_RST pulse width should be more than 500ns (because of FO_RST input filter circuit).

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4. FO INPUT TIMING DIAGRAM

When FO is pulled down to low level in case the FO of other phases becomes low level (fault happened) or the MCU/DSP sets FO to low level, the outputs (HOUT, LOUT) of the driver will be shut down. As soon as FO goes high again, the output will respond to the following active input signal.

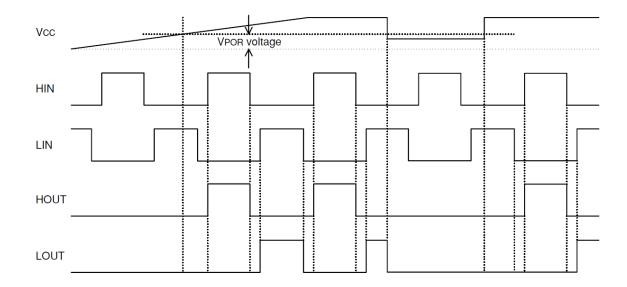


Note1 : Delay times between input and output signals are not shown in the figure above.

Note2 : The minimum FO pulse width should be more than 500ns (because of FO input filter circuit).

5. LOW SIDE VCC SUPPLY POWER RESET SEQUENCE

When the VCC supply voltage is lower than power reset trip voltage, the power reset gets active and the outputs (HOUT/LOUT) become "L". As soon as the VCC supply voltage goes higher than the power reset trip voltage, the outputs will respond to the following active input signals.



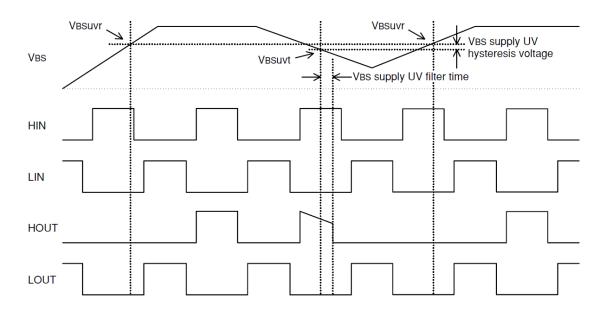
Note1 : Delay times between input and output signals are not shown in the figure above

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6. HIGH SIDE VBS SUPPLY UNDER VOLTAGE LOCKOUT SEQUENCE

When VBS supply voltage drops below the VBS supply UV trip voltage and the duration in this status exceeds the VBS supply UV filter time, the output of the high side is locked. As soon as the VBS supply voltage rises above the VBS supply UV reset voltage, the output will respond to the following active HIN signal.

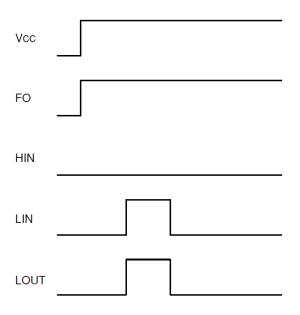


Note1 : Delay times between input and output signals are not shown in the figure above.

7. POWER START-UP SEQUENCE

At power supply start-up the following sequence is recommended when bootstrap supply topology is used.

- ① Apply VCC.
- ② Make sure that FO is at high level.
- ③ Set LIN to high level and HIN to low level so that bootstrap capacitor could be charged.
- ④ Set LIN to low level.

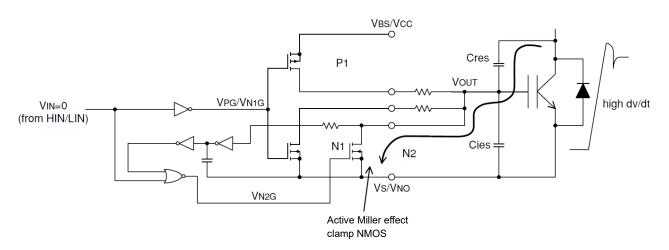


Note : If two power supply are used for supplying VCC and VBS individually, it is recommended to set VCC first and then set VBS.

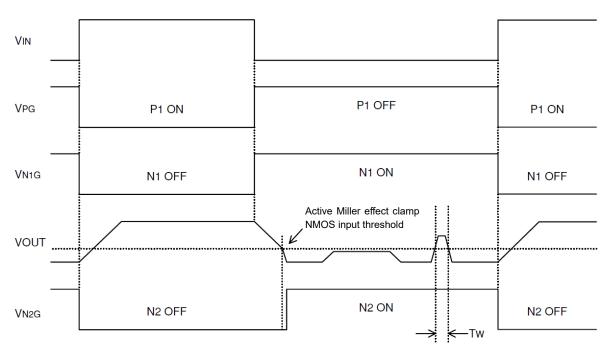
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8. ACTIVE MILLER EFFECT CLAMP NMOS OUTPUT TIMING DIAGRAM

The structure of the output driver stage is shown in following figure. This circuit structure employs a solution for the problem of the Miller current through Cres in IGBT switching applications. Instead of driving the IGBT gate to a negative voltage to increase the safety margin, this circuit structure uses a NMOS to establish a low impedance path to prevent the self-turn-on due to the parasitic Miller capacitor in power switches.



When HIN/LIN is at low level and the voltage of the VOUT (IGBT gate voltage) is below active Miller effect clamp NMOS input threshold voltage, the active Miller effect clamp NMOS is being turned on and opens a low resistive path for the Miller current through Cres.

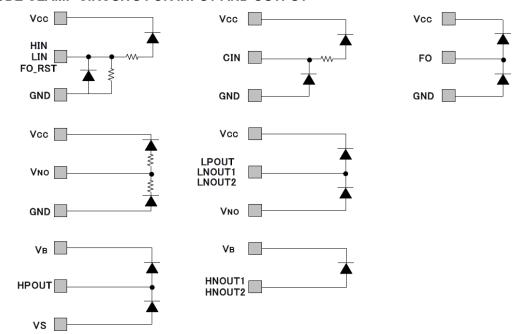


Active Miller effect clamp NMOS keeps turn-on if Tw does not exceed active Miller clamp NMOS filter time

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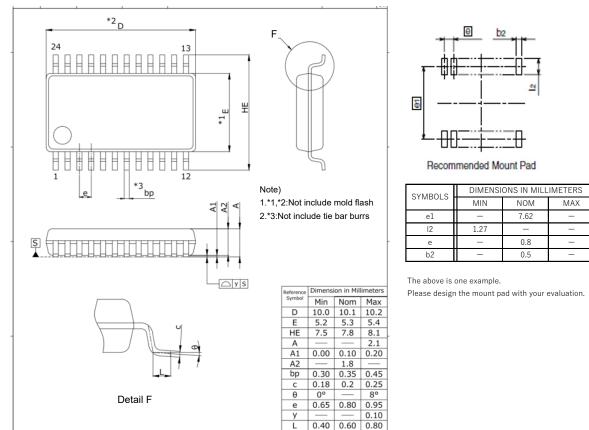
INTERNAL DIODE CLAMP CIRCUITS FOR INPUT AND OUTPUT



ENVIRONMENTAL CONSCIOUSNESS

M81738FP is compliant with the Restriction of the Use of Certain Hazardous Substances in Electrical and Electronic Equipment (RoHS) directive 2011/65/EU+(EU)2015/863.

PACKAGE OUTLINE



<hvic> M81738FP 1200V high voltage half bridge driver

Main Revision for this Edition

	Revision			
	Points	Pages	Date	Rev.
	New making	-	10 Jan. 2012	A
	"PRELIMINARY" is deleted.	-	3 Dec. 2014	В
	"TL" is added.	2		
	"ENVIRONMENTAL CONSCIOUSNESS" is added.	10		
	Change V _{BSuvr} for V _{BSuvt}	4	19 Jun. 2019	С
_	Update format	-	28 Apr. 2021	D
	Change "W" to " Ω " about the unit of $R_{OH},\ R_{OL1}$ and R_{OL2}	4	26 Jul. 2022	E

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